Search Notes



Appli	ication/	Contro	oN Ic
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Examiner

Kirk, Lameka J

Applicant(s)/Patent Under Reexamination

CHEN ET AL.

Art Unit

2609

SEARCHED

Class	Subclass	Date	Examiner
370	310	4/25/2007	lk
370	351	4/25/2007	lk
370	400-402	4/25/2007	lk
370	328	4/25/2007	ik

SEARCH NOTES

Search Notes	Date	Examiner
EAST search	4/25/2007	LK
PLUS search	4/25/2007	LK
Steven Nyugen (primary 370)	4/25/2007	LK

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner